Search Notes	•

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/053,340	WARE ET AL.	
Examiner	Art Unit	
Than Nguyen	2187	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
167,168	7/27/2007	NTV			
	Subclass	Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST IEEE Inventor	7/27/2007	NTV	
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